## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | ARIGA, KENICH| Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,438,385	08-2002	Heinonen et al.	455/501
	В	US-6,343,213	01-2002	Steer et al.	455/411
	С	US-6,625,455	09-2003	Ariga, Kenichi	455/456.1
	D	US-6,052,577	04-2000	Taguchi, Masayuki	455/411
	E	US-6,131,045	10-2000	Iwata, Shinichiro	340/7.39
	F	US-6,226,495	05-2001	Neustein, Simon	340/311.2
	G	US-5,224,150	06-1993	Neustein, Simon	340/7.44
	Н	US-			
	ī	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	O					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.